

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/057,406	WERENICZ ET AL.	
Examiner	Art Unit	
leff Η Δftergut	1733	

SEARCHED					
Class	Subclass	Date	Examiner		
updated previous search	,	श्रीयू०५	SAR		
			-		
	,,				

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
		,				
L						

SEARCH I (INCLUDING SEAR	NOTES CH STRATEGY	<b>(</b> )
	DATE	EXMR
		, i